## In the claims:

- 1-19 (canceled)
- 20. (previously presented) An integrated circuit, comprising:
- a first dielectric layer disposed outwardly from a substrate;
- a plurality of gate stacks, each gate stack comprising:
  - a floating gate body disposed outwardly from the first dielectric layer;
  - a second dielectric region disposed outwardly from the floating gate body; and
  - a first polysilicon layer disposed outwardly from the second dielectric region;
- a plurality of dielectric isolation regions disposed between the gate stacks, the dielectric isolation regions formed after the formation of the gate stacks;
- a second. polysilicon layer disposed outwardly from the first polysilicon layer and the dielectric isolation regions;
- a peripheral dielectric layer disposed outwardly from the second polysilicon layer and a peripheral region of the substrate, the peripheral region of the substrate disposed adjacent to a region of the substrate supporting the gate stacks;
- at least one peripheral gate body disposed outwardly from the peripheral region of the substrate.